



20V N-CHANNEL ENHANCEMENT MODE MOSFET

Product Summary

V _{(BR)DSS}	R _{DS(on)} max	I _D max T _A = +25°C (Note 6)
201/	20mΩ @ V _{GS} = 4.5V	9.8A
20V	28mΩ @ V _{GS} = 2.5V	8.3A

Description and Applications

This MOSFET has been designed to minimize the on-state resistance $(R_{DS(on)})$ and yet maintain superior switching performance, making it ideal for high efficiency power management applications.

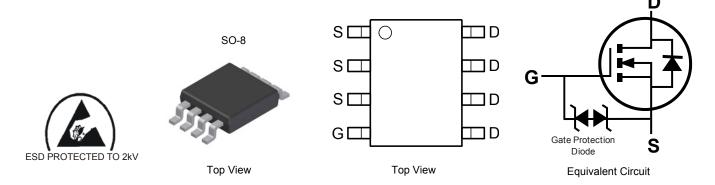
- Battery charging
- Power management functions
- DC-DC converters
- Portable power adaptors

Features and Benefits

- Low On-Resistance
- Low Input Capacitance
- Fast Switching Speed
- Low Output Leakage
- ESD Protected Up to 2kV
- Totally Lead-Free & Fully RoHS Compliant (Notes 1 & 2)
- Halogen and Antimony Free. "Green" Device (Note 3)
- Qualified to AEC-Q101 Standards for High Reliability

Mechanical Data

- Case: SO-8
- Case Material: Molded Plastic, "Green" Molding Compound. UL Flammability Classification Rating 94V-0 (Note 1)
- Moisture Sensitivity: Level 1 per J-STD-020
- Terminal Connections: See Diagram Below
- Terminals: Finish Matte Tin annealed over Copper leadframe.
 Solderable per MIL-STD-202, Method 208
- Weight: 0.074 grams (approximate)



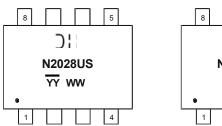
Ordering Information (Note 4)

Product	Marking	Reel size (inches)	Tape width (mm)	Quantity per reel
DMN2028USS-13	N2028US	13	12	2 500

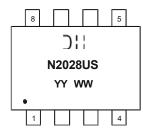
Notes:

- 1. No purposely added lead. Fully EU Directive 2002/95/EC (RoHS) & 2011/65/EU (RoHS 2) compliant.
- 2. See http://www.diodes.com/quality/lead_free.html for more information about Diodes Incorporated's definitions of Halogen- and Antimony-free, "Green" and Lead-free.
- 3. Halogen- and Antimony-free "Green" products are defined as those which contain <900ppm bromine, <900ppm chlorine (<1500ppm total Br + Cl) and <1000ppm antimony compounds.
- 4. For packaging details, go to our website at http://www.diodes.com/products/packages.html.

Marking Information







Shanghai A/T Site

¬¡; = Manufacturer's Marking
N2028US = Product Type Marking Code
YYWW = Date Code Marking
YY or YY = Year (ex: 13 = 2013)
WW = Week (01 - 53)

YY = Date Code Marking for SAT (Shanghai Assembly/ Test site)
YY = Date Code Marking for CAT (Chengdu Assembly/ Test site)



Maximum Ratings ($@T_A = +25^{\circ}C$, unless otherwise specified.)

Characteristic		Symbol	Value	Unit	
Drain-Source voltage		V_{DSS}	20	V	
Gate-Source voltage		V_{GS}	±12	V	
		(Note 6)		9.8	
Continuous Drain current V _{GS} = 4.5V	$V_{GS} = 4.5V$	$T_A = +70^{\circ}C \text{ (Note 6)}$	I _D	7.9	
		(Note 5)		7.3	Α
Pulsed Drain current	$V_{GS} = 4.5V$	(Note 7)	I _{DM}	45.0	
Continuous Source current (Body diode)	(Note 6)	Is	6.0	
Pulsed Source current (Body	y diode)	(Note 7)	I _{SM}	45.0	

Thermal Characteristics (@T_A = +25°C, unless otherwise specified.)

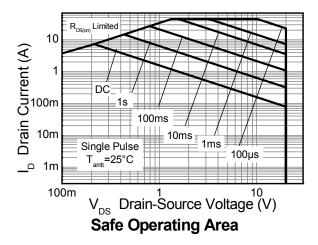
Characteristic		Symbol	Value	Unit	
Power dissipation	(Note 5))	1.56 12.5		
Linear derating factor	(Note 6)	P _D	2.81 22.5	mW/°C	
Thermal Decistores, Junction to Ambient	(Note 5)	-	80.0		
Thermal Resistance, Junction to Ambient	(Note 6)	$R_{\theta JA}$	44.5	°C/W	
Thermal Resistance, Junction to Lead	(Note 8)	$R_{ hetaJL}$	37.0		
Operating and storage temperature range		T _J , T _{STG}	-55 to +150	°C	

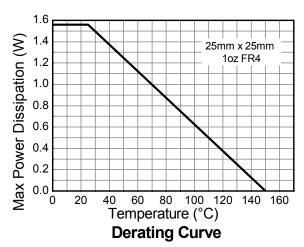
Notes:

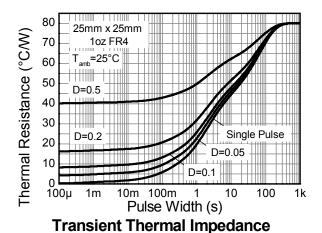
- 5. For a device surface mounted on 25mm x 25mm x 1.6mm FR4 PCB with high coverage of single sided 1oz copper, in still air conditions; the device is measured when operating in a steady-state condition.
 6. Same as note (5), except the device is measured at t ≤ 10 sec.
- 7. Same as note (5), except the device is pulsed with D = 0.02 and pulse width $300\mu s$.
- 8. Thermal resistance from junction to solder-point (at the end of the drain lead).

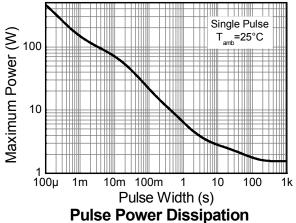


Thermal Characteristics









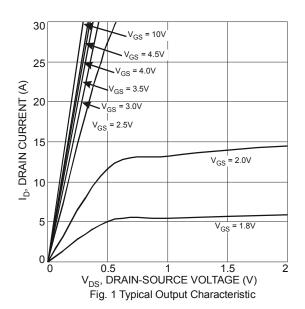


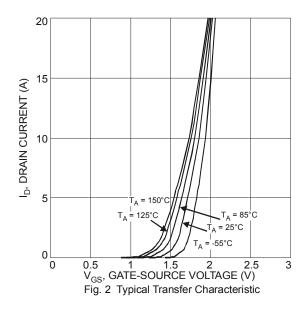
Electrical Characteristics (@T_A = +25°C, unless otherwise specified.)

Characteristic	Symbol	Min	Тур	Max	Unit	Test Condition	
OFF CHARACTERISTICS							
Drain-Source Breakdown Voltage	BV _{DSS}	20	-	-	V	$V_{GS} = 0V, I_D = 250\mu A$	
Zero Gate Voltage Drain Current	I _{DSS}	-	-	1.0	μA	$V_{DS} = 20V, V_{GS} = 0V$	
Gate-Source Leakage	I _{GSS}	-	-	±10	μA	$V_{GS} = \pm 12V, V_{DS} = 0V$	
ON CHARACTERISTICS		-					
Gate Threshold Voltage	$V_{GS(th)}$	0.6	1.0	1.3	V	$V_{DS} = V_{GS}, I_{D} = 250 \mu A$	
Static Drain-Source On-Resistance (Note 9)	В		11	20	mΩ	$V_{GS} = 4.5V, I_D = 9.4A$	
Static Dialit-Source Off-Resistance (Note 9)	R _{DS (ON)}	-	15	28	11122	$V_{GS} = 2.5V, I_D = 8.3A$	
Forward Transfer Admittance (Note 9 & 10)	Y _{fs}	-	16	-	S	$V_{DS} = 5V, I_D = 9.4A$	
Diode Forward Voltage (Note 9)	V _{SD}	-	0.7	1.3	V	$V_{GS} = 0V, I_S = 1.3A$	
DYNAMIC CHARACTERISTICS (Note 10)							
Input Capacitance	C _{iss}	-	1000	-		101/11/	
Output Capacitance	Coss	-	166	-	pF	$V_{DS} = 10V, V_{GS} = 0V,$	
Reverse Transfer Capacitance	C _{rss}	-	158	-	f = 1.0MHz		
Gate Resistance	Rg	-	1.51	-	Ω	V _{DS} = 0V, V _{GS} = 0V, f = 1MHz	
Total Gate Charge (Note 11)	Qq	-	7.0	-		V _{GS} = 2.5V	
Total Gate Charge (Note 11)	Qq	-	11.6	-		$V_{GS} = 4.5V$ $V_{DS} = 10V$ $I_{D} = 9.4A$	
Gate-Source Charge (Note 11)	Q _{gs}	-	2.7	-	nC		
Gate-Drain Charge (Note 11)	Q _{gd}	-	3.4	-			
Turn-On Delay Time (Note 11)	t _{D(on)}	-	11.67	-		V _{GS} = 4.5V, V _{DS} = 10V,	
Turn-On Rise Time (Note 11)	t _r	-	12.49	-			
Turn-Off Delay Time (Note 11)	t _{D(off)}	-	35.89	-	ns	$R_G = 6\Omega$, $I_D = 1A$	
Turn-Off Fall Time (Note 11)	t _f	-	12.33	-			

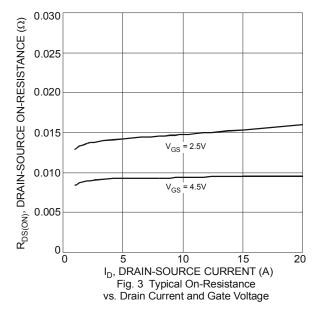
Notes:

- 9. Measured under pulsed conditions. Pulse width $\leq 300 \mu s;$ duty cycle $\leq 2\%$
- For design aid only, not subject to production testing.
 Switching characteristics are independent of operating junction temperatures.









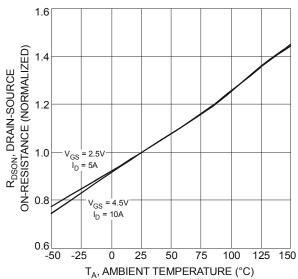
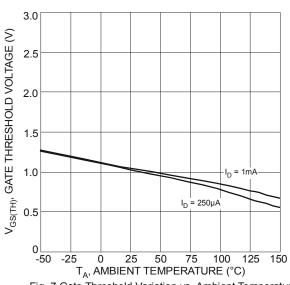
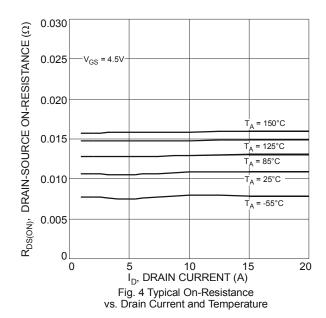


Fig. 5 On-Resistance Variation with Temperature







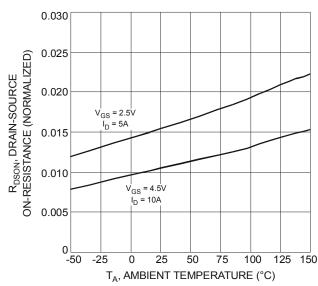
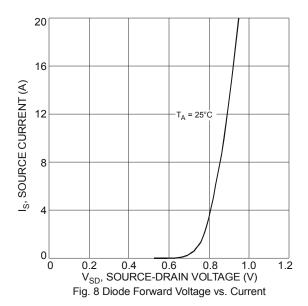
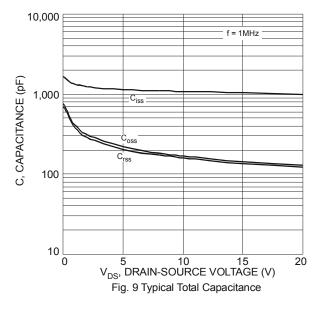
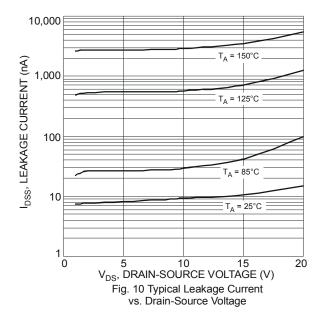


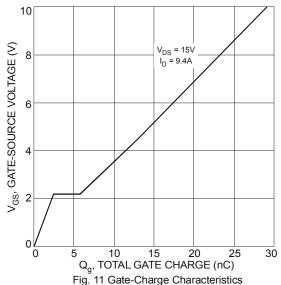
Fig. 6 On-Resistance Variation with Temperature





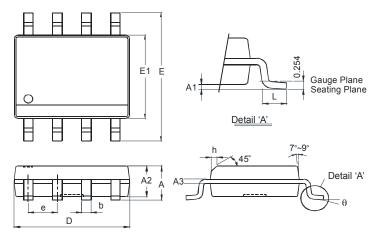






Package Outline Dimensions

Please see AP02002 at http://www.diodes.com/datasheets/ap02002.pdf for latest version.



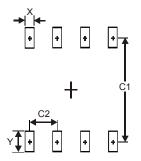
SO-8					
Dim	Min	Max			
Α	-	1.75			
A1	0.10	0.20			
A2	1.30	1.50			
A3	0.15	0.25			
b	0.3	0.5			
D	4.85	4.95			
Е	5.90	6.10			
E1	3.85	3.95			
е	1.27 Typ				
h	1	0.35			
L	0.62	0.82			
θ	0°	8°			
All Dimensions in mm					

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Suggested Pad Layout

Please see AP02001 at http://www.diodes.com/datasheets/ap02001.pdf for the latest version.



Dimensions	Value (in mm)
X	0.60
Υ	1.55
C1	5.4
C2	1.27

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